

Notice of References Cited

Application/Control No.

10/830,180

Applicant(s)/Patent Under

Reexamination

WAKAO ET AL.

Examiner

PONNOREAY PICH

Art Unit

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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-2004/0133550	07-2004	Okamura, Koki	707/001
*	B US-6,434,538	08-2002	Ibaraki et al.	705/57
*	C US-2002/0093573	07-2002	Cromer et al.	348/231
*	D US-2004/0039929	02-2004	Decime, Jerry	713/193
*	E US-5,499,294	03-1996	Friedman, Gary L.	713/179
*	F US-2004/0013268	01-2004	de Queiroz, Ricardo L.	380/201
*	G US-6,968,058	11-2005	Kondoh et al.	380/200
*	H US-7,154,535	12-2006	Yamasaki et al.	348/207.1
*	I US-6,636,844	10-2003	Yoneyama, Kaoru	707/1
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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P					
Q					
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S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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